

**Notice of References Cited**

Application/Control No.

09/387,534

Applicant(s)/Patent Under  
Reexamination  
DUJMENOVIC ET AL.

Examiner

Annan Q Shang

Art Unit

2614

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,388,713	05-2002	Saiki et al.	348/353
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	A	US-6,388,713	05-2002	Saiki et al.	348/353
	B	US-5,122,878	02-1992	Heigl et al.	358/191.1
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